

FDG314P

Digital FET, P-Channel

General Description

This P-Channel enhancement mode field effect transistor is produced using Fairchild Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize onstate resistance at low gate drive conditions. This device is designed especially for battery power applications such as notebook computers and cellular phones. This device has excellent on-state resistance even at gate drive voltages as low as 2.5 volts.

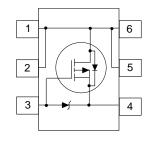
Applications

- Power Management
- Load switch
- Signal switch

Features

- -0.65 A, -25 V. R_{DS(ON)} = 1.1 Ω @ V_{GS} = -4.5 V R_{DS(ON)} = 1.5 Ω @ V_{GS} = -2.7 V.
- Very low gate drive requirements allowing direct operation in 3V cirucuits (V_{GS(th)} <1.5 V).
- Gate-Source Zener for ESD ruggedness (>6 kV Human Body Model).
- Compact industry standard SC70-6 surface mount package.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | -25 | V |
| V _{GSS} | Gate-Source Voltage | | ±8 | V |
| I _D | Drain Current - Continuous | (Note 1a) | -0.65 | A |
| | - Pulsed | | -1.8 | |
| P _D | Power Dissipation for Single Operation | (Note 1a) | 0.75 | W |
| | | (Note 1b) | 0.48 | |
| T _J , T _{stg} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |
| ESD | Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf/1500 Ohm) | | 6.0 | kV |

Thermal Characteristics

| R _{eJA} Thermal Resistance, Junction-to-Ambient (Note 1b) 260 °C/W |
|---|
|---|

Package Marking and Ordering Information

| - | Device Marking | Device | Reel Size | Tape Width | Quantity | |
|---|----------------|---------|-----------|------------|------------|--|
| | -14 | FDG314P | 7" | 8mm | 3000 units | |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|---|--|-------|----------------------|-------------------|-------|
| Off Chara | acteristics | | | • | • | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$ | -25 | | | V |
| $\Delta BV_{DSS} \over \Delta T_J$ | Breakdown Voltage Temperature Coefficient | I_D = -250 μ A, Referenced to 25°C | | -19 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -20 V, V _{GS} = 0 V | | | -1 | μΑ |
| I _{GSS} | Gate-Body Leakage Current | $V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Chara | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | -0.65 | -0.72 | -1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | I_D = -250 μ A, Referenced to 25°C | | 2 | | mV/°C |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = -4.5 \text{ V}, I_D = -0.5 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -0.5 \text{ A}$ @ 125°C $V_{GS} = -2.7 \text{ V}, I_D = -0.25 \text{ A}$ | | 0.77 1.08 1.06 | 1.1 1.8 1.5 | Ω |
| I _{D(on)} | On-State Drain Current | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$ | -1 | | | Α |
| g FS | Forward Transconductance | $V_{DS} = -4.5 \text{ V}, I_{D} = -0.5 \text{ A}$ | | 0.9 | | S |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ | | 63 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 34 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 10 | | pF |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -6 \text{ V}, I_{D} = -0.5 \text{ A},$ | | 7 | 20 | ns |
| t _r | Turn-On Rise Time | V_{GS} = -4.5 V, R_{GEN} = 50 Ω | | 8 | 20 | ns |
| t _{d(off)} | Turn-Off Delay Time | 1 | | 55 | 110 | ns |
| t _f | Turn-Off Fall Time | 1 | | 35 | 70 | ns |
| Qg | Total Gate Charge | $V_{DS} = -5 \text{ V}, I_{D} = -0.25 \text{ A},$ | | 1.1 | 1.5 | nC |
| Q _{gs} | Gate-Source Charge | $V_{GS} = -4.5 \text{ V}$ | | 0.32 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 0.25 | | nC |
| Drain-So | urce Diode Characteristics | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source | | | | -0.42 | Α |
| V _{SD} | Drain-Source Diode Forward | $V_{GS} = 0 \text{ V}, I_S = -0.42 \text{ A}$ (Note 2) | | -0.85 | -1.2 | V |

Notes:

^{1.} R_{QJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{QJC} is guaranteed by design while R_{QCA} is determined by the user's board design.

a) 170°C/W when mounted on a 1 in² pad of 2oz copper.

b) 260°C/W when mounted on a minimum mounting pad.

^{2.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

Typical Characteristics

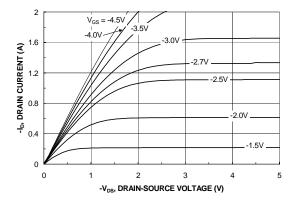


Figure 1. On-Region Characteristics.

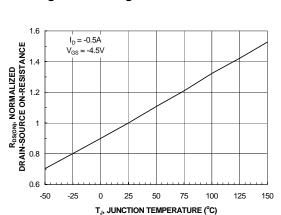


Figure 3. On-Resistance Variation with Temperature.

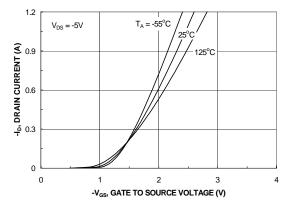


Figure 5. Transfer Characteristics.

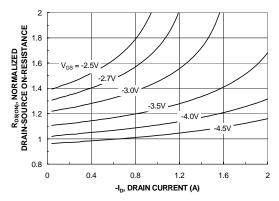


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

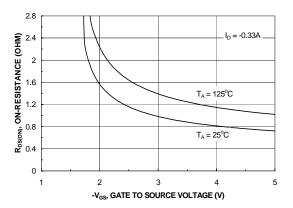


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

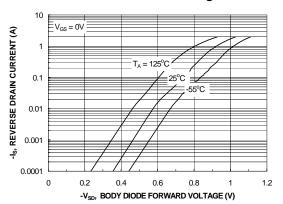
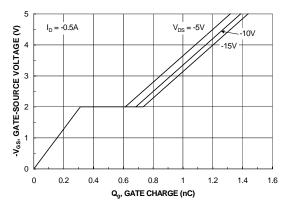


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)



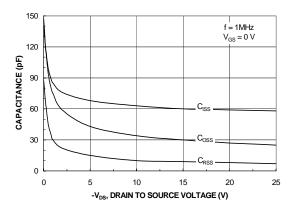
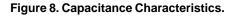
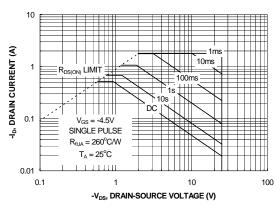


Figure 7. Gate-Charge Characteristics.





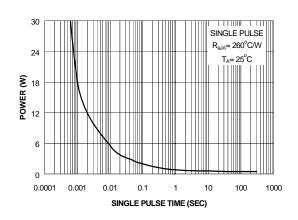


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

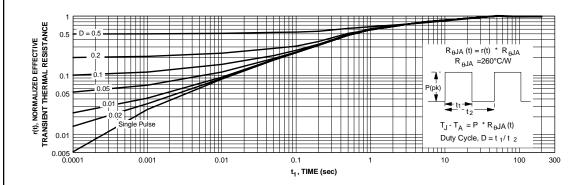


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient themal response will change depending on the circuit board design.

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